

April 1988 Revised July 1999

74F132

Quad 2-Input NAND Schmitt Trigger

General Description

The F132 contains four 2-input NAND gates which accept standard TTL input signals and provide standard TTL output levels. They are capable of transforming slowly changing input signals into sharply defined, jitter-free output signals. In addition, they have a greater noise margin than conventional NAND gates.

Each circuit contains a 2-input Schmitt Trigger followed by level shifting circuitry and a standard FAST™ output struc-

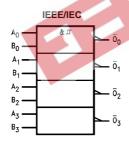
ture. The Schmitt Trigger uses positive feedback to effectively speed-up slow input transitions, and provide different input threshold voltages for positive and negative-going transitions. This hysteresis between the positive-going and negative-going input threshold (typically 800 mV) is determined by resistor ratios and is essentially insensitive to temperature and supply voltage variations.

Ordering Code:

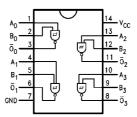
Order Number	Package Number	Package Description
74F132SC	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150 Narrow
74F132SJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74F132PC	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbol



Connection Diagram



Unit Loading/Fan Out

I	Din Names	Danasissias	U.L.	Input I _{IH} /I _{IL}		
	Pin Names	Description	HIGH/LOW	Output I _{OH} /I _{OL}		
	A _n , B _n	Inputs	1.0/1.0	20 μA/-0.6 mA		
	\overline{O}_n	Outputs	50/33.3	-1 mA/20 mA		

Function Table

Inputs		Outputs		
Α	В	ō		
L	L	Н		
L	Н	Н		
Н	L	Н		
Н	Н	L		

H = HIGH Voltage Level L = LOW Voltage Level

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Absolute Maximum Ratings(Note 1)

Recommended Operating Conditions

Storage Temperature $-65^{\circ}\text{C} \text{ to } +150^{\circ}\text{C}$

Ambient Temperature under Bias -55° C to +125 $^{\circ}$ C Junction Temperature under Bias -55° C to +150 $^{\circ}$ C

 $\begin{array}{lll} \text{V}_{\text{CC}} \text{ Pin Potential to Ground Pin} & -0.5 \text{V to } +7.0 \text{V} \\ \text{Input Voltage (Note 2)} & -0.5 \text{V to } +7.0 \text{V} \\ \text{Input Current (Note 2)} & -30 \text{ mA to } +5.0 \text{ mA} \\ \end{array}$

Voltage Applied to Output in HIGH State (with $V_{CC} = 0V$)

Standard Output -0.5V to V_{CC} 3-STATE Output -0.5V to +5.5V

Current Applied to Output

in LOW State (Max) twice the rated I_{OL} (mA) ESD Last Passing Voltage (Min) 4000V

Free Air Ambient Temperature $0^{\circ}\text{C} \text{ to } +70^{\circ}\text{C}$ Supply Voltage +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

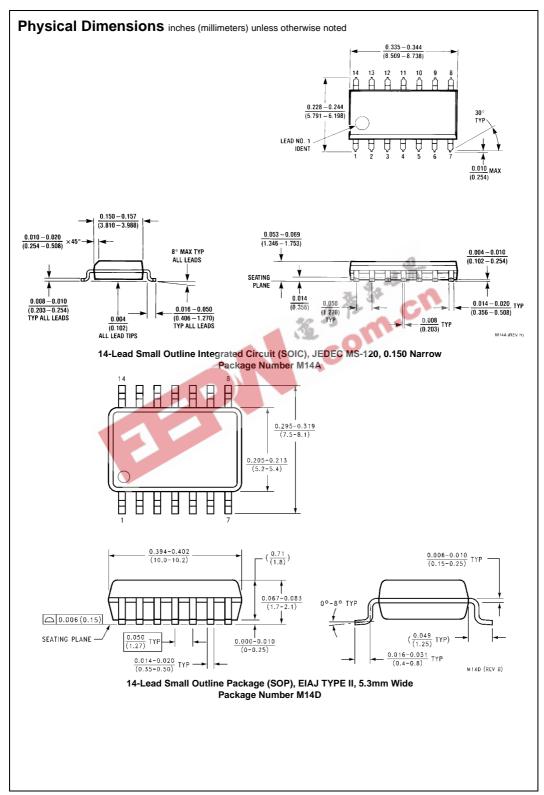
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DC Electrical Characteristics

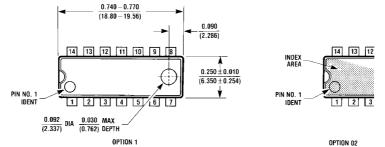
Symbol	Parameter	Min	Тур	Max	Units	V _{CC}	Conditions
V_{T+}	Positive-going Threshold	1.5		2.0	V	5.0	
V_{T-}	Negative-going Threshold	0.7		1.119	V	5.0	
ΔV_{T}	Hysteresis (V _T ⁺ – V _T ⁻)	0.4	30	4) '	V	5.0	
V _{CD}	Input Clamp Diode Voltage		V. T.	-1.2	V	Min	I _{IN} = -18 mA
V _{OH}	Output HIGH 10% V _{CC}	2.5		100	V	Min	I _{OH} = -1 mA
	Voltage 5% V _{CC}	2.7					$I_{OH} = -1 \text{ mA}$
V _{OL}	Output LOW Voltage 10% V _{CC}	1 1		0.5	V	Min	I _{OL} = 20 mA
I _{IH}	Input HIGH Current			5.0	μΑ	Max	V _{IN} = 2.7V
I _{BVI}	Input HIGH Current Breakdown Test			7.0	μΑ	Max	V _{IN} = 7.0V
I _{CEX}	Output HIGH Leakage Current			50	μΑ	Max	$V_{OUT} = V_{CC}$
V _{ID}	Input Leakage Test	4.75			V	0.0	I _{ID} = 1.9 μA All Other Pins Grounded
I _{OD}	Output Leakage Circuit Current			3.75	μА	0.0	V _{IOD} = 150 mV All Other Pins Grounded
I _{IL}	Input LOW Current			-0.6	mA	Max	V _{IN} = 0.5V
Ios	Output Short-Circuit Current	-60		-150	mA	Max	$V_{OUT} = 0V$
I _{CCH}	Power Supply Current			17.0	mA	Max	V _O = HIGH
I _{CCL}	Power Supply Current			18.0	mA	Max	$V_O = LOW$

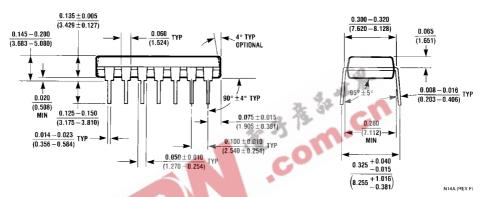
AC Electrical Characteristics

	Parameter	$T_A = +25^{\circ}C$			T _A = 0°C to +70°C		Units	
Symbol		V _{CC} = +5.0V C _L = 50 pF			V _{CC} = +5.0V C _L = 50 pF			
		Min	Тур	Max	Min	Max	1	
t _{PLH}	Propagation Delay	4.0		10.5	3.5	12.0	ns	
t _{PHL}	A_n , B_n to \overline{O}_n	5.0		12.5	5.0	13.0	115	



Physical Dimensions inches (millimeters) unless otherwise noted (Continued)





14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N14A

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